

## Article

# Color Glass by Layered Nitride Films for Building Integrated Photovoltaic (BIPV) System

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**Abstract:** We investigated layered titanium nitride (TiN) and aluminum nitride (AlN) for color glasses in Building Integrated Photovoltaic (BIPV) systems. AlN and TiN are among suitable and cost-effective optical materials to be used as thin multilayer films, owing to the significant difference in their refractive index. To fabricate the structure, we used radio frequency magnetron deposition method to achieve the target thickness uniformly. A simple, fast, and cheap fabrication method is achieved by depositing the multilayer films in a single sputtering chamber. It is demonstrated that a multilayer stack that allows light to move from a low refractive index layer to a high refractive index layer or vice-versa can effectively create various distinct color reflections for different film thicknesses and multilayer structures. It is investigated from simulation based on wave optics that, TiN/AlN multilayer offers better color design freedom and cheaper fabrication process as compared to AlN/TiN multilayer films. Blue, green, and yellow color glasses with optical transmittance of more than 80% was achieved by ITO coated glass/TiN/AlN multilayer films. This technology exhibits good potential in commercial BIPV system applications.

**Keywords:** BIPV, color glass, thin film interference, optical path-length difference, RF Sputtering, nitride, multilayer film

## 1. Introduction

BIPV system provides a novel and an efficient technique for solar energy to be harvested from the envelope of buildings and to generate renewable energy mainly for the constructed environment [1,2]. Photovoltaics (PVs) have attracted much research interest and have been established several decades ago [3-4]. Recently, the introduction of organic photovoltaics - the technology to convert sunlight into electricity by employing thin films of organic semiconductors - has been the subject of active research and has received increased interest in recent years by the industrial sector [5,6]. This technology has the potential to birth a new generation of low-cost, solar-powered products with thin and flexible form factors. BIPV concepts which are based on PVs are a prime way to reach net-zero energy buildings. Large scale application and integration of solar energy technologies has enabled the general adoption and extension of distributed energy generation in buildings of all size and use across the world. This way, a significant portion of the electricity generated is consumed within the built environment, reducing the cost of electricity generation, transport, and distribution by smart grids [7].

Though BIPV systems are primarily attached to buildings to generate electricity, their general adoption as integrated solar energy system and functional materials for the building envelope is mainly hindered by aesthetic considerations. Conventional solar systems installed on large areas of buildings (roofs and facades) come in standard black or grey solar modules, mostly due to the antireflective coating layers within the PV cell [8]. This is generally not well accepted by most users. An approach to solving this problem is adopting front color glasses that can hide the active

components of the PV cell but transmits the non-reflected radiation entirely to the absorber with little or no absorption and can withstand degradation over time [9,10]. When such color glasses replace the conventional front glasses of both PV and thermal solar panels, architectural integration of solar panels into glazed building facades becomes an attractive choice.

While the choice of color is good for architecture, the colored appearance should not cause excessive energy loss and instability. Various concepts have been proposed for optical applications in color glasses for BIPV systems. Some conventional approaches adopt pigment-based coloring, which however absorbs radiation and does not withstand degradation over time [11]. Recently, some solutions have adopted optical color films based on interference effect from thin multilayer films [12-15]. The color is derived based on the interference in the reflected light from the different interfaces of the thin multilayer film [16-19]. The incident light undergoes reflection and refraction at every interface where multiple rays are reflected into the air and multiple rays transmitted through the film. The reflected rays interfere with each other, their phase difference being determined by their optical path difference (OPD) [19,20]. The degree of constructive or destructive interference between the reflected waves depends on the difference in their phases. The OPD depends on the thickness, the refractive index, and the angle of incidence of the original wave on the film. Normally, a phase shift of  $180^\circ$  ( $\pi$  radians) may be introduced upon reflection at a boundary depending on the refractive indices of the materials on either side of the boundary [19].

Kromatix™ technology [13] applied multilayer coating on the inner glass surface by atomic layer deposition in a low-pressure plasma process. Atomic layer deposition is considered to have a great potential for producing thin, uniform, and conformal films with accurate thickness control at less substrate damage [21]. However, its major limitation is slow growth rate, hence expensive to be considered for large area commercial applications in BIPV systems. Unfortunately, most of the materials selected for the multilayer structures have low refractive indices [14, 22-23]. Consequently, thick layers are required to achieve bright and desired colors. This approach is expensive, requires long deposition time, and yields layers with low transmittance and cannot be applied in BIPV systems. Moreover, the effect of the structure on the optical properties of the multilayer has been elusive and must be fully investigated.

Recently, we reported color glasses BIPV systems using multilayer thin films composed of metal oxide layers [14,15]. We verified through computer simulation based on wave optics that metal oxide thin layers with significant difference in their refractive index could be integrated to realize different colors with good transmittance. Several reports have also investigated that nitrides and other dielectrics can be applied in passivation applications for advanced transparent flexible OLEDs and other organic electronic devices [24]. So far, most of the investigations have only focused on optical transparency of the dielectrics used in passivation applications. For advance and cheap PV's, it is only novel to adopt color films that can double as passivation films.

In this paper, we investigated color glass for BIPV system using multilayer thin films composed of TiN and AlN layers. The significant difference in the refractive index of TiN and AlN provides a multilayer that significantly changes the OPD of the reflected and transmitted spectra when the layer thickness is adjusted. The TiN and AlN layers were deposited by radio frequency reactive sputtering at room temperature. Aesthetically considerable blue, green, and yellow color glasses were fabricated from the derivatives of the Glass/ITO/TiN/AlN multilayer structure. A uniform color glass with high transmittance more than 80% is demonstrated. The TiN and AlN multilayer and the proposed deposition technique provide a simple, fast, and cheap fabrication method to make color glasses that are applicable for BIPV systems.

## 2. Materials and Methods

Glass/AlN/TiN and Glass/TiN/AlN multilayers herein referred to as Multilayer A and Multilayer B respectively, have been investigated as shown by the schematic structures in Fig. 1. For the given incident light on the thin films, there are reflected rays produced at each boundary whose OPDs depend on thickness and refractive index of the layers, and the angle of incidence.

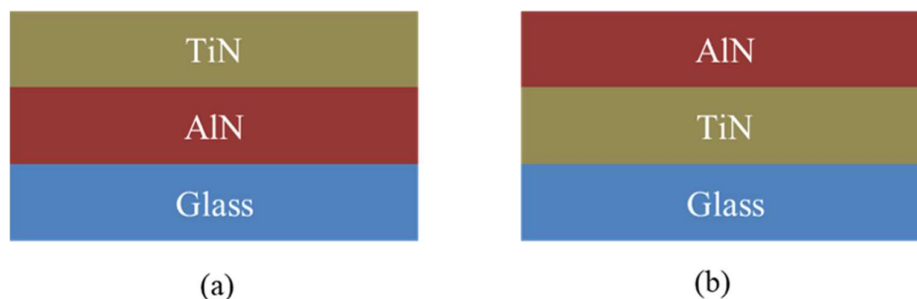


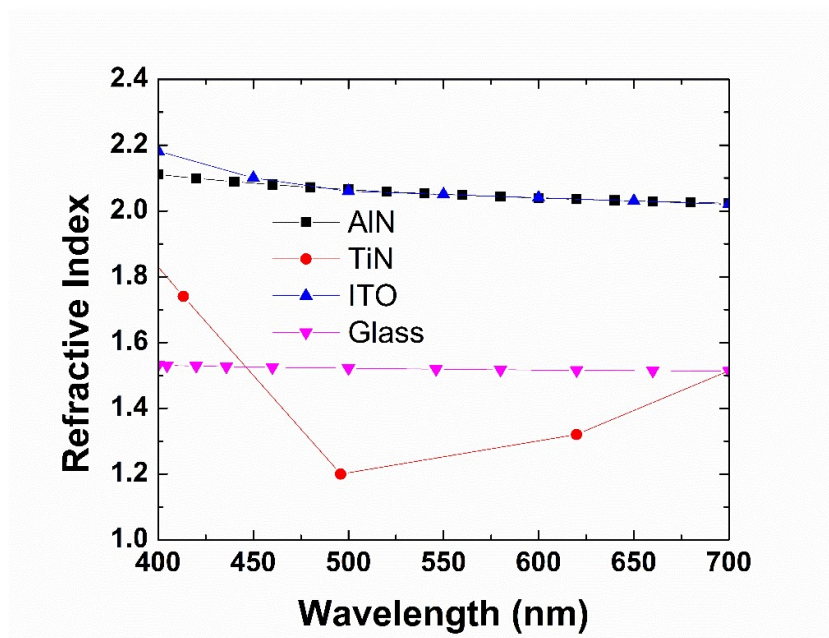
Figure 1. Schematic structure of (a) Multilayer A and (b) Multilayer B.

99.999% aluminum and titanium targets of 100 mm diameter were purchased from Sigma-Aldrich and iTASCO respectively. Argon (Ar) and Nitrogen (N<sub>2</sub>) gases were nominally 99.999% pure. All materials were used as received. Unpatterned ITO (150 nm) glass substrates (2.5 cm x 2.5 cm) were used to fabricate the color glasses after cleaning sequentially with acetone and isopropyl alcohol in an ultrasonic bath, boiled in isopropyl alcohol and dried in an oven at 150 °C for 15 minutes, respectively. TiN and AlN layers were deposited by a reactive sputtering system using the commercial aluminum and titanium targets respectively in a high vacuum base pressure of 2.4 mTorr. The nitride depositions were carried out in plasma created from Ar and N<sub>2</sub> gas mixtures by varying the partial pressures of gases with a mass flow controller (Nexttron, Korea). The controlled plasma was formed adjacent to the substrate by a 300-W radio frequency energy applied using an RF power generator. The plasma dissociates the entering process gases into ions and radicals that will be deposited onto the substrate surface. A working pressure of 20 mTorr was maintained during sputtering. Pre-sputtering was conducted for about 30 minutes to remove oxygen from chamber and stabilize the plasma state.

Thin film optical simulation based on wave optics was done using Essential Macleod software program by Thin Film Center Inc. The optical transmittance and reflectance of the films were measured by Ultraviolet-visible-near infrared spectrophotometry (Lambda 950 UV-vis-NIR spectrophotometer, PerkinElmer). The thickness of the TiN and AlN films were determined from alpha step measurements.

### 3. Results and Discussions

#### 3.1. Simulation and analysis



**Figure 2.** (a) Refractive index of AlN, TiN, ITO, and Glass

The simulation analysis was made based on the refractive index of the materials provided in the database of Essential Macleod software. The reported refractive index of AlN, TiN, ITO, and Glass within visible range is shown in Fig. 2. The refractive index at 510 nm for glass, ITO, TiN and AlN is 1.5, 2.1, 1.2 and 2.1, respectively. The nitrides exhibit a refractive index difference of 0.9 at 510 nm which is suitable for thin film multilayer interference. Generally, AlN exhibits similar refractive index characteristics with ITO while that of TiN is lower than glass, especially for incident beams with wavelengths between 450 nm and 700 nm.

The 3D simulation profile of the reflectance as a function of thickness and wavelength of TiN and AlN are shown in Fig. 3, respectively. For the TiN layer as shown in Fig. 3 (a), increase of thickness to 50 nm increased reflectance to 23%. For wavelengths below 500 nm, the reflectance remains below 20% for layers more than 50 nm. However, for other wavelengths above 500 nm, the reflectance increases steadily. For the AlN layer as shown in Fig. 3 (b), the reflectance of AlN increased to 23% at 50 nm, decreased to 4% at 100 nm, increased back to 23% at 180 nm, and then decreased to 4.2% at 200 nm in that sequence. The above characteristics demonstrate that the reflectance and transmittance characteristics of the TiN and AlN multilayer films can be uniquely tuned by the thickness of the layers and the incident beams.

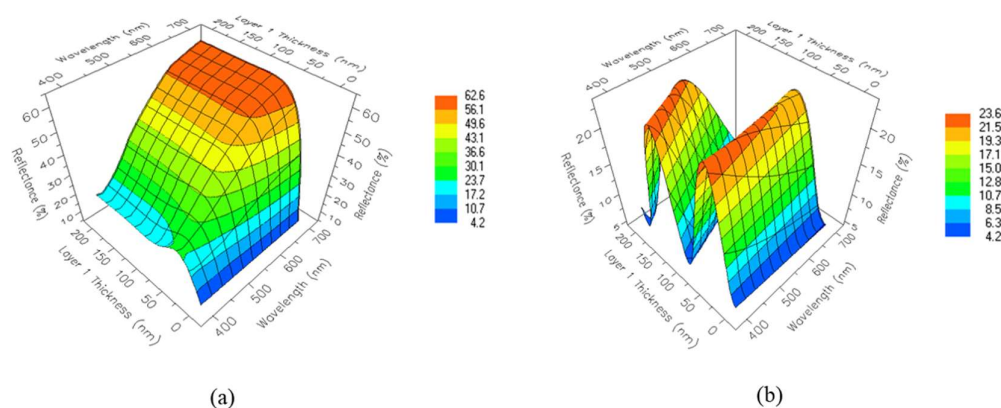


Figure 3. Simulation of reflectance profile of (a) TiN and (b) AlN.

The effect of multilayer structure on the thin film interference using computer simulation based on wave optics is further investigated. For Multilayer A, light traverses air, through to the TiN layer. Since the refractive index of TiN is higher than air, the reflection that occurs at the air-TiN boundary of the film introduces a  $180^\circ$  phase shift in the reflected wave [19,20]. Part of the beam is then transmitted through the AlN layer and is similarly reflected with a phase shift. Similar interferences occur at the AlN-glass and glass-air boundaries. However, there is no phase shift in the reflected light at the AlN-glass boundary since the beam travels from a medium with higher refractive index into a medium with lower refractive index. In the Multilayer B, reflections occur for some wavelengths at the air-AlN, AlN-TiN, TiN-glass, and glass-air interfaces, respectively. The remaining light is transmitted sequentially through a series of alternating layers with low and high refractive index, respectively. Thus, the optical path traversed by the transmitted beam differs in the two multilayer structures. Generally, the color produced by the thin film interaction of each multilayer depends on the constructive and destructive interference of the reflected rays at each interface. The OPD of the reflected beams from the boundaries of each multilayer are obtained for each constructive and destructive interference of the reflected light, respectively [19,20]. The simulated color profiles for Multilayer A and Multilayer B are shown in Fig. 4, respectively.

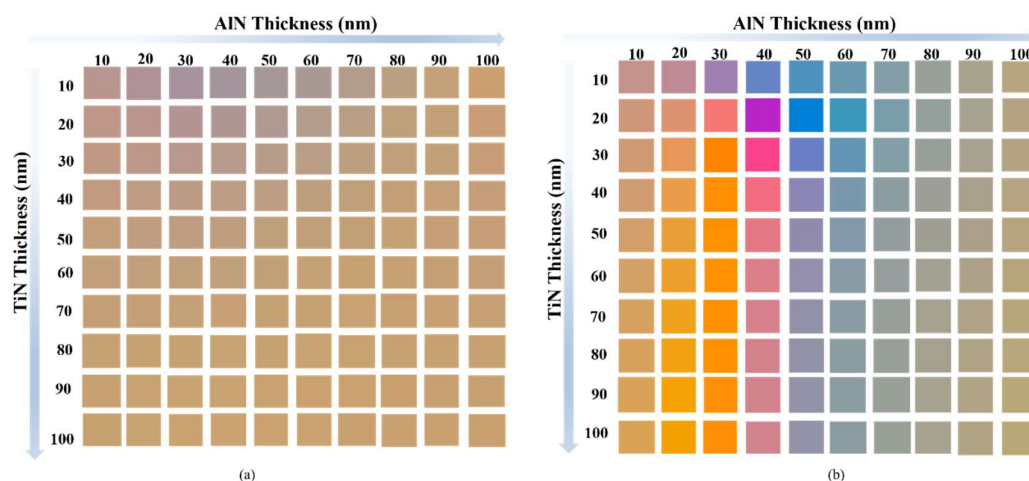


Figure 4. Simulated color profile of Multilayer A and Multilayer B.

The color profile for Multilayer A is shown in Fig. 4 (a). Generally, it is shown that it is difficult to achieve various colors, even when thick layers of TiN and AlN are deposited. In cases where thick layers are deposited, the overall fabrication becomes expensive and requires long processing time. It is most preferred to have freedom of color choice for commercial application in BIPV. Therefore, from the perspective of large scale commercial optical applications, the Multilayer A is not suitable. Figure



4 (b) shows the simulated color profile for Multilayer B. It is demonstrated that various bright color films can be achieved, especially for layers deposited below 50 nm. This can be attributed to different OPD obtained by the Multilayer B when the thickness of the layers is tuned. For each incident beam, a unique constructive interference for different film thicknesses is achieved. Thus, from the perspective of commercial application, Multilayer B provides one of the best methods for achieving color glasses as cost and processing time are minimized as compared to the other reported approaches. Thus, our fabricated color films are based on Multilayer B. Consequently, our fabricated color films are based on the Multilayer B. Color glasses of choice can be easily fabricated by tuning the thickness of the layers.

### 3.2. Samples analysis

The TiN layer has a refractive index lower than glass which makes it difficult to achieve several color films with Glass/TiN/AlN. As such, for lab scale fabrication and demonstration, ITO coated glass substrates were used. Four color glass derivatives of Multilayer B herein referred to as M1, M2, M3 and M4 were fabricated based on ITO coated Glass/TiN (30 nm)/AlN (30 nm), ITO coated Glass/TiN (30 nm)/AlN (50 nm), ITO coated Glass/TiN (30 nm)/AlN (30 nm)/TiN (30 nm) and ITO coated Glass/TiN (30 nm)/AlN (50 nm)/TiN (30 nm) multilayers, respectively. The actual photographs of the fabricated M1, M2, M3 and M4 color glasses are shown in Fig. 5. The photographs of the samples were taken on two backgrounds – black surface and solar cell – respectively.

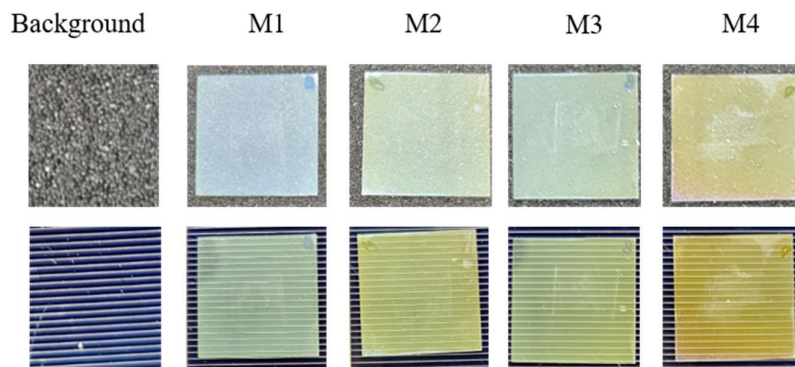


Figure 5. Photograph of M1, M2, M3 and M4 color glasses.

M3 and M4 were achieved by depositing an additional layer of TiN (30 nm) on M1 and M2, respectively. M1 and M2 show shades of blue and green color glasses, respectively. It is demonstrated that tuning the thickness of the AlN changes the color of the film. M3 and M4 also show shades of green and yellow, respectively. Notable color deviation of samples from simulation may be due to thickness variation of the deposited layers from those in the simulation.

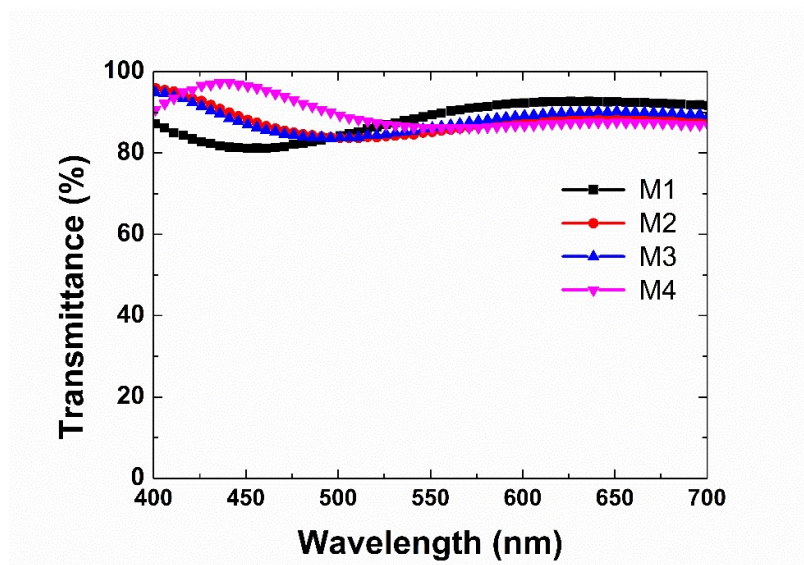


Figure 6. Transmittance of M1, M2, M3 and M4 color glasses

The transmittance spectra of M1, M2, M3 and M4 color glasses within visible range are shown in Fig. 6. Maximum transmittance of more than 80% is achieved for all color glasses. The minimum transmittance peaks for M1, M2, M3 and M4 color glasses are 81% at 452 nm, 84% at 505 nm, 84% at 493 nm and 86% at 553 nm, respectively. In BIPV systems, it is desired that color glasses have high transmittance to ensure high efficiency. We have successfully demonstrated that color glasses with high transmittance of more than 80% can be achieved. For additional layers of TiN, reflectance of wavelengths above 500 nm are highly reflected as discussed in Fig. 3 (a). Hence it is confirmed in the M3 and M4 color glasses that transmittance is suppressed for incident beams with wavelengths more than 500 nm as compared to incident beams below 500 nm. The reflectance and transmittance of the color glasses can be tuned by the high refractive index material – AlN. The validation of the simulated results can be further enhanced by simulating with measured refractive index and thickness of films. Since AlN has similar refractive index with ITO, it is expected that color glasses can be fabricated solely with AlN and TiN without coating the glass substrates with ITO.

#### 4. Conclusions

We fabricated color glasses for BIPV systems using multilayer thin films composed of titanium nitride and aluminum nitride layers. The high refractive index AlN layer, combined with the low refractive index TiN layer provided an effective multilayer structure for achieving desired colors with good transmittance. It was investigated that the multilayer structure and the thickness of the AlN and TiN layers can tune the color and transmittance of the film. Blue, green, and yellow color glasses were achieved with the ITO coated glass/TiN/AlN multilayer structure by tuning the number and thickness of the layers. It is successfully demonstrated that color glasses with high transmittance of more than 80% can be achieved. The proposed multilayer structure and the adopted sputtering technique allows cheap and desirable color glasses to be implemented in commercial BIPV systems and other photonic devices.

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**Conflicts of Interest:** The authors declare no conflicts of interest.

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